Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/720,472	JUN, JUNG SIG
Examiner	Art Unit
Krista M. Flanagan	2631

SEARCHED				
Class	Subclass	Date	Examiner	
375	261 316 321 326 340 350	5/26/2005	KMF	
375	270	5/26/2005	KMF	
348	725 726	5/26/2005	KMF	
348	<b>32</b> 5	5/26/2005	KMF	
329	304 306	5/26/2005	KMF	
329	307 308	5/26/2005	KMF	
329	357	5/26/2005	KMF	
375	355 327	5/26/2005	KMF	
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
375	326	11/23/2005	KMF		
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	SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR			
EAST	5/26/2005	KMF			
Inventor Search	5/26/2005	KMF			
Updated Search - See search notes for details	11/23/2005	KMF			